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World Standardization Certification & Testing Group (Shenzhen) Co., ltd.

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FCC NFC RF Exposure Report

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For

INFINIX MOBILITY LIMITED

FLAT N 16/F BLOCK B UNIVERSAL INDUSTRIAL CENTRE 19-25 SHAN MEI

STREET FOTAN NT HONGKONG

Model: X6856

X	Test Engineer: Zeng Longhao Zeng Lon	ghas	
WSCT	Report Number: WSCT-ANAB-R&E241200075	A-SAR	
. Carrielle	Report Date: 06 January 2025	iscation & Testing Go	X
	W5CT FCC/ID: 72AIZN-X6856 W5CT	Supervision of the second	WSET
WSET	Check By: Jiang Xuling Jiang Luling	T WSL	
	Approved By: Li Huaibi L; Huaibi	\mathbf{X}	\sim
	World Standardization Certificatio	n & Testing Group	WSET
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Member of the WSCT Group	P(WSCTSA) Page 1 of 8	WSET	WSET



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Report No.: WSCT-ANAB-R&E241200075A-SAR SAR Evaluation Report





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Report No.: WSCT-ANAB-R&E241200075A-SAR SAR Evaluation Report

Modified History

8	THE PART				Total .
1	REV.	Modification Description	Issued Date	Remark	
\times	REV.1.0	Initial Test Report Relesse	06 January 2025	Li Huaibi	
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General information

WS7/1.1 Notes

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The test results of this test report relate exclusively to the test item specified in this test report. Shenzhen Timeway Testing Laboratories does not assume responsibility for any conclusions and generalisations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item. The test report is not to be reproduced or published in full without the prior written permission.

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ANSI National Accreditation Board

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1.2 EUT Information

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Device Information:		260
Product Type:	Mobile Phone	
Model:	X68567 WSCT WSCT	
Trade Name:	Infinix	\bigvee
Device Type:	Portable device	
Exposure Category:	uncontrolled environment / general population	SET
Production Unit or Identical Prototype:	Production Unit	
Software version :	X6856-15.0.1 WSCT WSCT	
Hardware version:	V1.2	Х
NFC Antenna Type :	Integral Antenna	SET
Device Operating Configuration	IS:	
Modulation:	ASK(NFC)	
Operation Frequency:	NFC: 13.553-13.567MHz(TX/RX)	\times
Power Source:	Rechargeable Li-ion Polymer Battery Model: BL-5ABX Rated Voltage: 3.86V Rated Capacity: 4900mAh/18.97Wh Typical Capacity: 5000mAh/19.35Wh Limited Charge Voltage: 4.45V	SCT

Note:1.The test results of this test report relate exclusively to the test item specified in this test report. World Standardization Certification & Testing Group (Shenzhen) Co.,Ltd does not assume responsibility for any conclusions and generalisations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item. The test report is not to be reproduced or published in full without the prior written permission.

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Report No.: WSCT-ANAB-R&E241200075A-SAR

Testing laboratory 2

	Test Site	World Standardization Certification & Testing Group (Shenzhen) Co., Ltd.
/		Building A-B,Baoli'an Industrial Park,No.58 and 60,Tangtou Avenue, Shiyan
V5 [Laboratory A.	Street, Bao'an District, Shenzhen City, Guangdong Province, China
		Building J-7F and Building D, Dongjiang Science & Technology Park, Tangjia
	Laboratory B:	Community, Fenghuang Street, Guangming District, Shenzhen City, Guangdong
		Province, China

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3 ACCREDITATIONS

Our laboratories are accredited and approved by the following approval agencies according

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/ to ISO/IEC 17025.4/5 / 7 WS

	CRTI	IECEE(international Electrotechnical Commiss, The	Laboratory A
	CBIL	certificate registration number is TL672)	Laboratory B
	China	CNAS (The cortificated registration number: 3732)	Laboratory A
2	China	CIAS (The certificated registration number: E3732)	Laboratory B
		A2LA (The cortificated registration number: 5768.01)	Laboratory A
	USA	AZEA (The certificated registration number: 5766.01)	Laboratory B
		ANAR (The cortificated registration number: AT 2051)	Laboratory A
	USA	ANAD (The certificated registration number.A1-5951)	Laboratory B

Copies of granted accreditation certificates are available for downloading from our web site,

http://www.wsct-cert.com

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Applicant and Manufacturer

<u>, C</u>	Applicant/Client Name:	INFINIX MOBILITY LIMITED
	Applicant Address:	FLAT N 16/F BLOCK B UNIVERSAL INDUSTRIAL CENTRE 19-25 SHAN MEI STREET FOTAN NT HONGKONG
	Manufacturer Name:	INFINIX MOBILITY LIMITED
X	Manufacturer Address:	FLAT N 16/F BLOCK B UNIVERSAL INDUSTRIAL CENTRE 19-25 SHAN MEI STREET FOTAN NT HONGKONG

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10 M # A-B Baoli'an Industrial Park No 58 采圳世际检测认证股份有限公司 FAX: 0086-755-86376605 3-755-26996192 26996053 26996144

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Test standard/s:

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\wedge	No.	Identity	Document Title	
'5 <i>C</i>	71	47 CFR Part 2.1093	Radiofrequency radiation exposure evaluation: portable devices	
	2	KDB447498 D01	General RF Exposure Guidance v06	7
	3	KDB447498 D04	Interim General RF Exposure Guidance v01	1

SAR Evaluation Report

Test result

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I .According KDB 447498 D01 4.3.1 General SAR test exclusion guidance

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Test Exclusion Threshold condition(s), listed below, is (are) satisfied. These test exclusion conditions are based on source-based time-averaged maximum conducted output power of the RF channel requiring evaluation, adjusted for tune-up tolerance, and the minimum test separation distance required for the exposure conditions. The minimum test separation distance defined in 4.1 f) is determined by the smallest distance from the antenna and radiating structures or outer surface of the device, according to the host form factor, exposure conditions and platform requirements, to any part of the body or extremity of a user or bystander. To qualify for SAR test exclusion, the test separation distances applied must be fully explained and justified, typically in the SAR measurement or SAR analysis report, by the operating configurations and exposure conditions of the transmitter and applicable host platform requirements, according to the required published RF exposure KDB procedures. When no other RF exposure testing or reporting are required, a statement of justification and compliance must be included in the equipment approval, in lieu of the SAR report, to qualify for SAR test exclusion. When required, the device specific conditions described in the other published RF exposure KDB procedures must be satisfied before applying these SAR test exclusion provisions; for example, handheld PTT two-way radios, handsets, WSET laptops and tablets, etc.

a) For 100 MHz to 6 GHz and test separation distances \leq 50 mm, the 1-g and 10-g SAR test exclusion thresholds are determined by the following:

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[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] \cdot [\checkmark f (GHz)] \leq 3.0 for 1-g SAR, and \leq 7.5 for 10-g extremity SAR, where

1).f (GHz) is the RF channel transmit frequency in GHz

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2) Power and distance are rounded to the nearest mW and mm before calculation

3) The result is rounded to one decimal place for comparison

4) The values 3.0 and 7.5 are referred to as numeric thresholds in step b) below

The test exclusions are applicable only when the minimum test separation distance is \leq 50 mm, and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation

distance is < 5 mm, a distance of 5 mm according to 4.1 f) is applied to determine SAR test exclusion. b) For 100 MHz to 6 GHz and test separation distances > 50 mm, the 1-g and 10-g SAR test exclusion thresholds are determined by the following (also illustrated in Appendix B):

1) {[Power allowed at numeric threshold for 50 mm in step a)] + [(test separation distance 50 mm)·(f (MHz) /150)]} mW, for 100 MHz to 1500 MHz

2) {[Power allowed at numeric threshold for 50 mm in step a)] + [(test separation distance – 50 mm) \cdot 10]} mW, for > 1500 MHz and \leq 6 GHz

c) For frequencies below 100 MHz, the following may be considered for SAR test exclusion (also illustrated in Appendix C):

1) For test separation distances > 50 mm and < 200 mm, the power threshold at the corresponding test separation distance at 100 MHz in step b) is multiplied by [1 + log(100/f (MHz))]

2) For test separation distances \le 50 mm, the power threshold determined by the equation in c) 1) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$

3) SAR measurement procedures are not established below 100 MHz.

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When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any SAR test results below 100 MHz to be acceptable.

Appendix C

SAR Test Exclusion Thresholds for < 100 MHz and < 200 mm

Approximate SAR test exclusion power thresholds at selected frequencies and test separation distances are illustrated in the following table. The equation and threshold in 4.3.1 must be applied to determine SAR test exclusion.

	MHz	< 50	50	60	70	80	90	100	110	120	130	140	150	160	170	180	190	mm
	100	237	474	481	487	494	501	507	514	521	527	534	541	547	554	561	567	
	50	308	617	625	634	643	651	660	669	677	686	695	703	712	721	729	738	
1	10	474	948	961	975	988	1001	1015	1028	1041	1055	1068	1081	1095	1108	1121	1135	
	1	711	1422	1442	1462	1482	1502	1522	1542	1562	1582	1602	1622	1642	1662	1682	1702	mW
2	0.1	948	1896	1923	1949	1976	2003	2029	2056	2083	2109	2136	2163	2189	2216	2243	2269	
	0.05	1019	2039	2067	2096	2125	2153	2182	2211	2239	2268	2297	2325	2354	2383	2411	2440	
	0.01	1185	2370	2403	2437	2470	2503	2537	2570	2603	2637	2670	2703	2737	2770	2803	2837	

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II . According to the ANSI C63.10 clause 11.12.2.2:

The general procedure for conducted measurements in restricted bands is as follows:

- a) Measure the conducted output power (in dBm) using the detector specified by the appropriate regulatory agency (see 11.12.2.3 through 11.12.2.5 for guidance regarding measurement procedures for determining quasi-peak, peak, and average conducted output power, respectively).
- b) Add the maximum transmit antenna gain (in dBi) to the measured output power level to determine the EIRP (see 11.12.2.6 for guidance on determining the applicable antenna gain).
- c) Add the appropriate maximum ground reflection factor to the EIRP (6 dB for frequencies ≤ 30 MHz;
 4.7 dB for frequencies between 30 MHz and 1000 MHz, inclusive; and 0 dB for frequencies > 1000 / MHz).
- d) For MIMO devices, measure the power of each chain and sum the EIRP of all chains in linear terms (i.e., watts and mW).

e) Convert the resultant EIRP to an equivalent electric field strength using the following relationship: E=EIRP -20 logd+104.8

					and the second se			
7			Max. E-Field		Ground			
	Mode	f (MHz)	strength	D (m)	reflection	EIRP (dBm)		
			(dBuV/m)		factor (dB)			
	NFC (13.56MHz)	13.56	72.77	3	6	-16.49		

Note:

1. Add the appropriate maximum ground reflection factor to the EIRP level (6 dB for frequencies \leq 30MHz).

2.EIRP= 72.77+20*Log(3)-104.8+6 =-16.49(dBm)

According to the FCC KDB 447498 D04

Estimated SAR: SAR test =1.6.Pant/Pth [W/kg]

Estimated SAR	1.6 ·Pant / Pth [W/kg]	
Pmeas.(dBm)	-16.49 Pmeas.(mW) 0.022439	\backslash
Pth.(mW)	474mW	X
NFC Estimated 1g SAR [W/kg]	<0.001	\sim
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Conclusion

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